

<b>Search Notes</b>	Application/Control No. 10511217	Applicant(s)/Patent Under Reexamination MONTVAY ET AL.
	Examiner Kim, Hee Soo	Art Unit 2109

### SEARCHED

Class	Subclass	Date	Examiner
370	60-61, 79	4/27/2007	HSK
709	201-253	4/27/2007	HSK
395	200.11	4/27/2007	HSK
455	550, 560	4/27/2007	

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	4/27/2007	HSK
George Neurauter (PS) at TC2100 search help	4/27/2007	HSK
Mustafa Meky (Primary/Search Mentor) search help	4/27/2007	HSK
William Vaughn (SPE) search help	4/27/2007	HSK

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner